


<b>Search Notes</b> 	<b>Application/Control No.</b> 10695888	<b>Applicant(s)/Patent Under Reexamination</b> NGUYEN ET AL.
	<b>Examiner</b> Dieu-Minh Le	<b>Art Unit</b> 2114

SEARCHED			
Class	Subclass	Date	Examiner
714	4,39,47,50,51,55	1/15/09	dml
709	223,224	1/15/09	dml
711	154,163	1/15/09	dml

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search files US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB, FPRS	1/15/09	dml
Inventor names search	1/15/09	dml
NPL search [IEEE, Google Scholar Search]	1/16/09	dml

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
714	4,39,47,50,55,51	1/15/09	dml
709	223,224	1/15/09	dml

	/Dieu-Minh Le/ Primary Examiner, Art Unit 2114
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